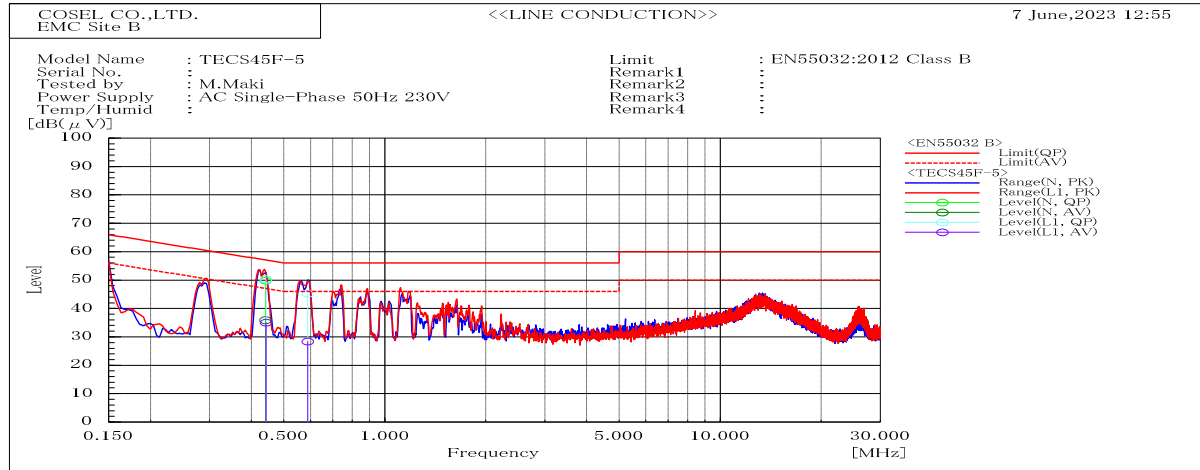
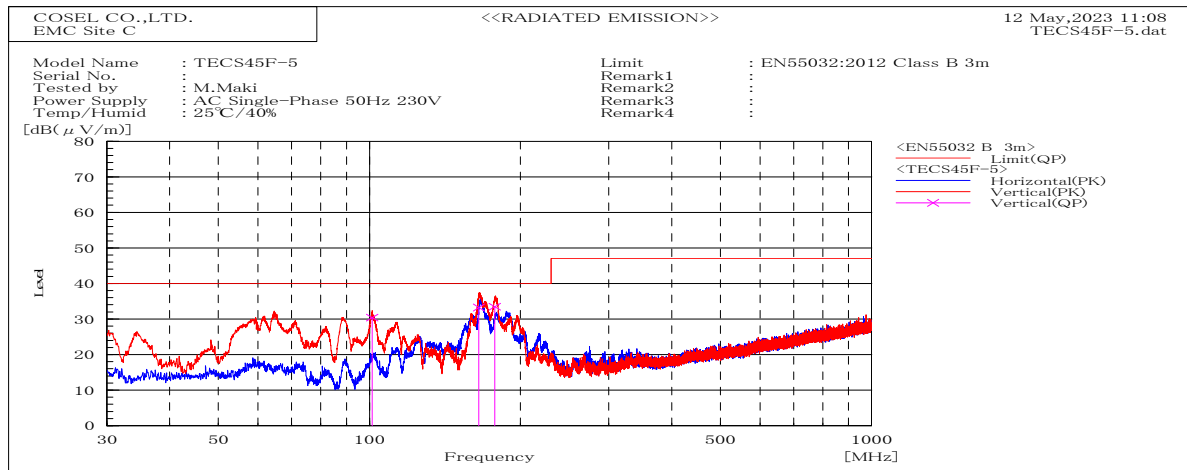


DATA SHEET		Date	12-Oct-23
Model	TECS45F-5	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	M.Maki



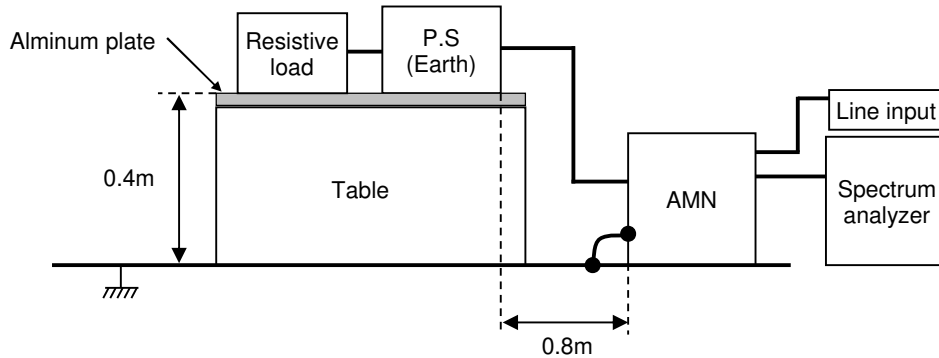
Frequency MHz	Line	Level dB(μV)		Limit dB(μV)		Margin dB		Pass/Fail	Remark
		QP	AV	QP	AV	QP	AV		
0.443	L1	50.3	35	57	47	6.7	12	Pass	
0.589	L1	45.2	28.4	56	46	10.8	17.6	Pass	
0.441	N	49.8	35.8	57	47	7.2	11.2	Pass	



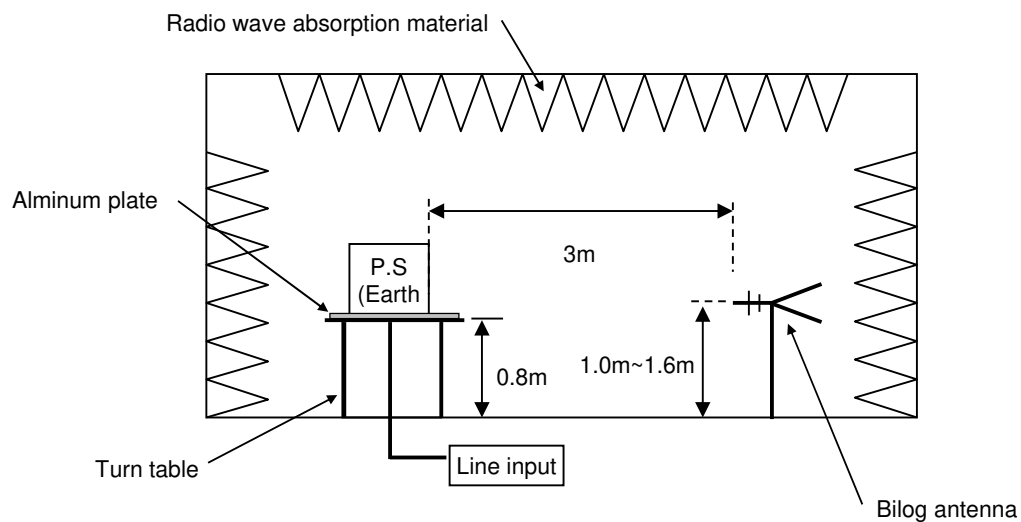
Frequency MHz	Polarization	Stability	Level dB(μV/m)		Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	QP	QP				
101.255	V	Stable	30.4	40	9.6	Pass	123.1	119	
165.187	V	Stable	33.2	40	6.8	Pass	100.2	0	
177.53	V	Stable	33.5	40	6.5	Pass	100.4	27.8	

DATA SHEET		Date	12-Oct-23
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	M.Maki

1. Line conduction



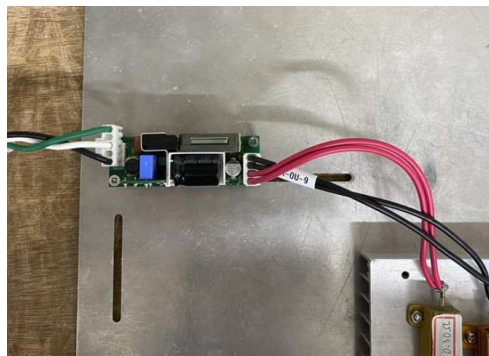
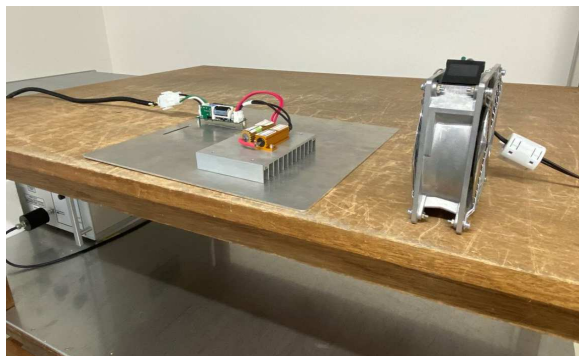
2. Radiated emission



Conditions

Test : EMI
Model Nam: TECS45F-5

1.LINE CONDUCTION



2.RADIATED EMISSION

